

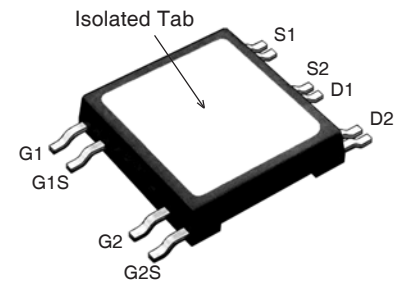
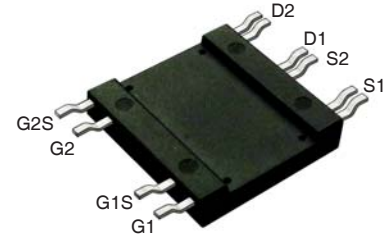
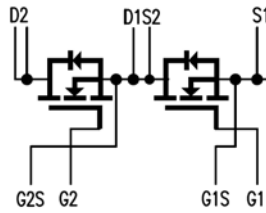
**Polar3™ HiperFET™
Power MOSFET**
MMIX2F60N50P3

$$V_{DSS} = 500V$$

$$I_{D25} = 30A$$

$$R_{DS(on)} \leq 120m\Omega$$

(Electrically Isolated Tab)

 N-Channel Enhancement Mode
 Avalanche Rated
 Fast Intrinsic Rectifier

 G = Gate D = Drain
 S = Source

| Symbol | Test Conditions | Maximum Ratings | |
|---------------|--|------------------|------------------|
| V_{DSS} | $T_J = 25^\circ\text{C}$ to 150°C | 500 | V |
| V_{DGR} | $T_J = 25^\circ\text{C}$ to 150°C , $R_{GS} = 1M\Omega$ | 500 | V |
| V_{GSS} | Continuous | ± 30 | V |
| V_{GSM} | Transient | ± 40 | V |
| I_{D25} | $T_C = 25^\circ\text{C}$ | 30 | A |
| I_{DM} | $T_C = 25^\circ\text{C}$, Pulse Width Limited by T_{JM} | 150 | A |
| I_A | $T_C = 25^\circ\text{C}$ | 30 | A |
| E_{AS} | $T_C = 25^\circ\text{C}$ | 1 | J |
| dv/dt | $I_S \leq I_{DM}$, $V_{DD} \leq V_{DSS}$, $T_J \leq 150^\circ\text{C}$ | 35 | V/ns |
| P_D | $T_C = 25^\circ\text{C}$ | 320 | W |
| T_J | | -55 ... +150 | $^\circ\text{C}$ |
| T_{JM} | | 150 | $^\circ\text{C}$ |
| T_{stg} | | -55 ... +150 | $^\circ\text{C}$ |
| T_L | Maximum Lead Temperature for Soldering | 300 | $^\circ\text{C}$ |
| T_{SOLD} | 1.6 mm (0.062in.) from Case for 10s | 260 | $^\circ\text{C}$ |
| V_{ISOL} | 50/60 Hz, 1 Minute | 2500 | V~ |
| F_C | Mounting Force | 50..200 / 11..45 | N/lb |
| Weight | | 8 | g |

| Symbol | Test Conditions ($T_J = 25^\circ\text{C}$ Unless Otherwise Specified) | Characteristic Values | | |
|--------------|---|-----------------------|------|--------------------------|
| | | Min. | Typ. | Max. |
| BV_{DSS} | $V_{GS} = 0V$, $I_D = 1mA$ | 500 | | V |
| $V_{GS(th)}$ | $V_{DS} = V_{GS}$, $I_D = 4mA$ | 3.0 | | 5.0 V |
| I_{GSS} | $V_{GS} = \pm 30V$, $V_{DS} = 0V$ | | | ± 100 nA |
| I_{DSS} | $V_{DS} = V_{DSS}$, $V_{GS} = 0V$ Note 2, $T_J = 125^\circ\text{C}$ | | | 25 μA 2 mA |
| $R_{DS(on)}$ | $V_{GS} = 10V$, $I_D = 30A$, Note 1 | | | 120 m Ω |

Features

- Silicon Chip on Direct-Copper Bond (DCB) Substrate
- Isolated Substrate
 - Excellent Thermal Transfer
 - Increased Temperature and Power Cycling Capability
 - High Isolation Voltage (2500V~)
- Fast Intrinsic Rectifier
- Avalanche Rated
- Low $R_{DS(ON)}$ and Q_G
- Low Package Inductance

Advantages

- High Power Density
- Easy to Mount
- Space Savings

Applications

- Switch-Mode and Resonant-Mode Power Supplies
- DC-DC Converters
- Laser Drivers
- AC and DC Motor Drives
- Robotics and Servo Controls

| Symbol | Test Conditions ($T_J = 25^\circ\text{C}$ Unless Otherwise Specified) | Characteristic Values | | |
|---|---|-----------------------|------|--------------------|
| | | Min. | Typ. | Max. |
| g_{fs} | $V_{DS} = 20\text{V}, I_D = 30\text{A}$, Note 1 | 35 | 60 | S |
| C_{iss} C_{oss} C_{rss} | } $V_{GS} = 0\text{V}, V_{DS} = 25\text{V}, f = 1\text{MHz}$ | | 6250 | pF |
| | | | 680 | pF |
| | | | 5 | pF |
| R_{Gi} | Gate Input Resistance | | 1.0 | Ω |
| $t_{d(on)}$ t_r $t_{d(off)}$ t_f | } Resistive Switching Times $V_{GS} = 10\text{V}, V_{DS} = 0.5 \cdot V_{DSS}, I_D = 30\text{A}$ $R_G = 1\Omega$ (External) | | 18 | ns |
| | | | 16 | ns |
| | | | 37 | ns |
| | | | 8 | ns |
| $Q_{g(on)}$ Q_{gs} Q_{gd} | } $V_{GS} = 10\text{V}, V_{DS} = 0.5 \cdot V_{DSS}, I_D = 30\text{A}$ | | 96 | nC |
| | | | 28 | nC |
| | | | 26 | nC |
| R_{thJC} R_{thCS} R_{thJA} | | | 0.39 | $^\circ\text{C/W}$ |
| | | 0.05 | | $^\circ\text{C/W}$ |
| | | 30 | | $^\circ\text{C/W}$ |

Source-Drain Diode

| Symbol | Test Conditions ($T_J = 25^\circ\text{C}$ Unless Otherwise Specified) | Characteristic Values | | |
|----------------------------------|---|-----------------------|------|---------------|
| | | Min. | Typ. | Max. |
| I_S | $V_{GS} = 0\text{V}$ | | | 60 A |
| I_{SM} | Repetitive, Pulse Width Limited by T_{JM} | | | 240 A |
| V_{SD} | $I_F = I_S, V_{GS} = 0\text{V}$, Note 1 | | | 1.4 V |
| t_{rr} I_{RM} Q_{RM} | } $I_F = 30\text{A}, -di/dt = 100\text{A}/\mu\text{s}$ $V_R = 100\text{V}, V_{GS} = 0\text{V}$ | | | 250 ns |
| | | | 11 | A |
| | | | 1.0 | μC |

Notes:

1. Pulse test, $t \leq 300\mu\text{s}$, duty cycle, $d \leq 2\%$.
2. Part must be heatsunk for high-temp I_{DSS} measurement.

PRELIMINARY TECHNICAL INFORMATION

The product presented herein is under development. The Technical Specifications offered are derived from data gathered during objective characterizations of preliminary engineering lots; but also may yet contain some information supplied during a pre-production design evaluation. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

IXYS Reserves the Right to Change Limits, Test Conditions, and Dimensions.

IXYS MOSFETs and IGBTs are covered 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585 7,005,734 B2 7,157,338B2
by one or more of the following U.S. patents: 4,860,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405 B2 6,759,692 7,063,975 B2
4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6,771,478 B2 7,071,537

Fig. 1. Output Characteristics @ $T_J = 25^\circ\text{C}$

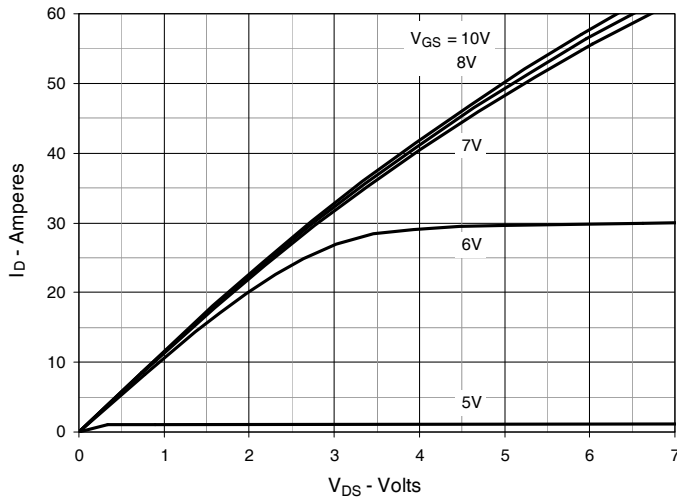


Fig. 2. Extended Output Characteristics @ $T_J = 25^\circ\text{C}$

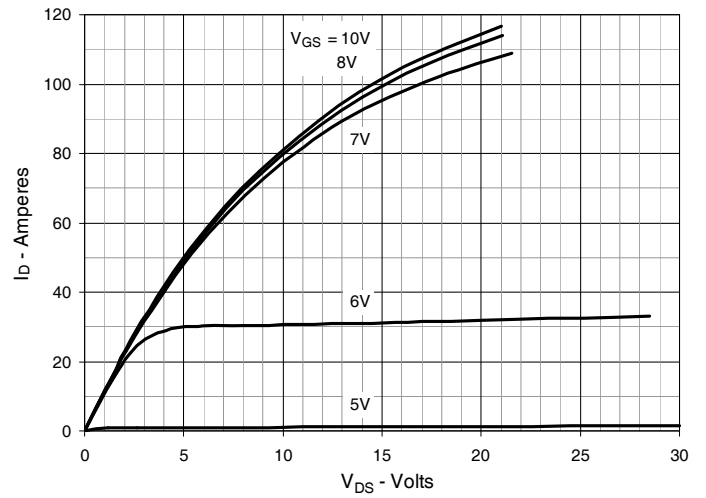


Fig. 3. Output Characteristics @ $T_J = 125^\circ\text{C}$

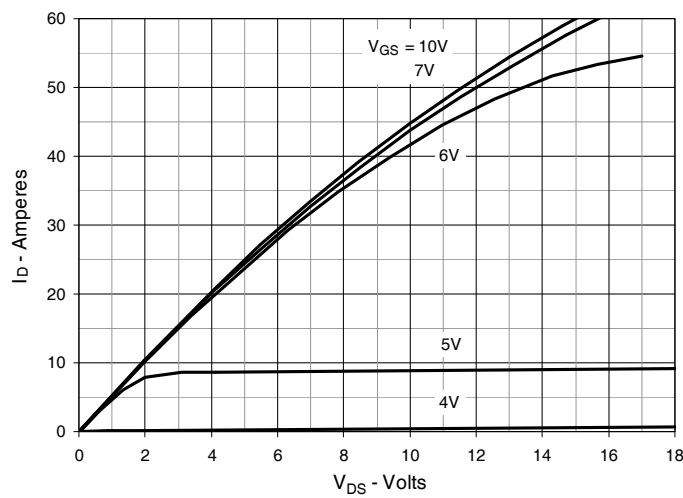


Fig. 4. $R_{DS(on)}$ Normalized to $I_D = 30\text{A}$ Value vs. Junction Temperature

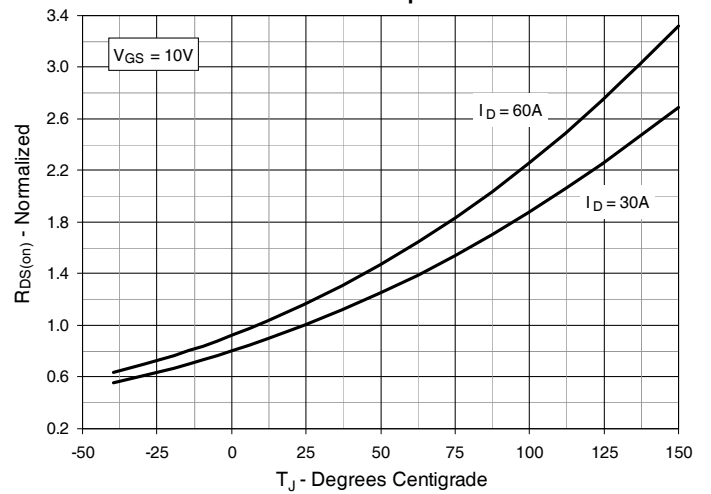


Fig. 5. $R_{DS(on)}$ Normalized to $I_D = 30\text{A}$ Value vs. Drain Current

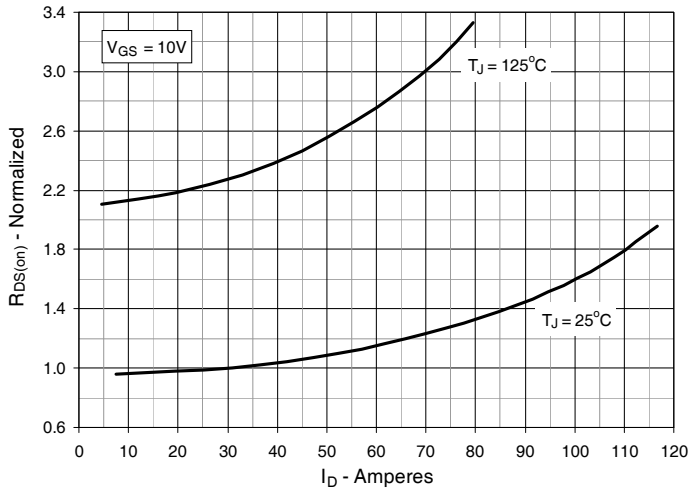


Fig. 6. Maximum Drain Current vs. Case Temperature

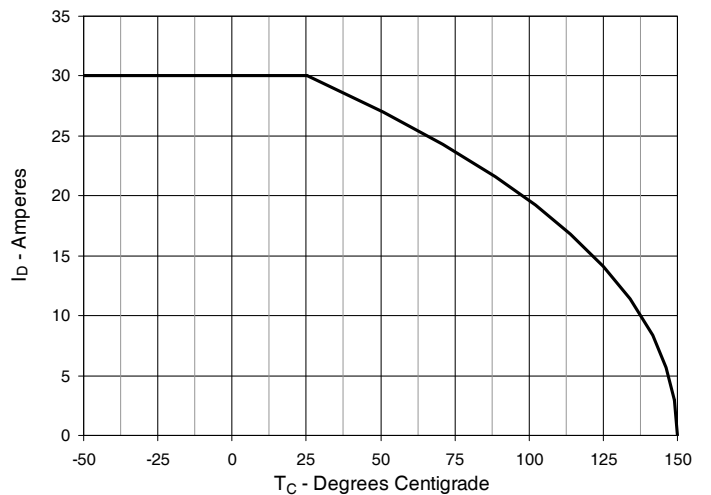


Fig. 7. Input Admittance

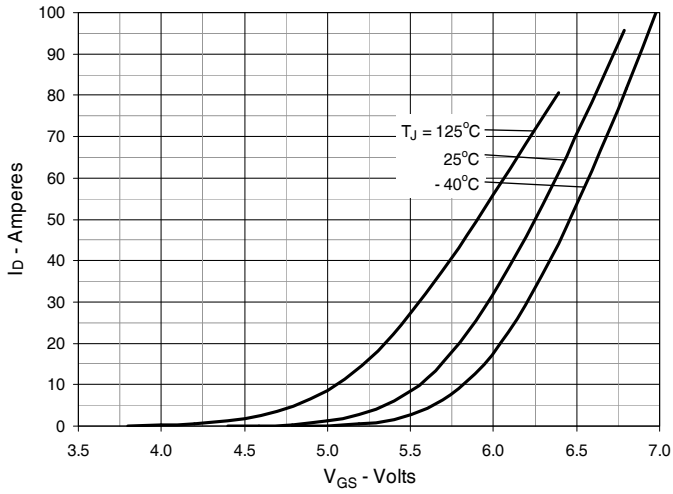


Fig. 8. Transconductance

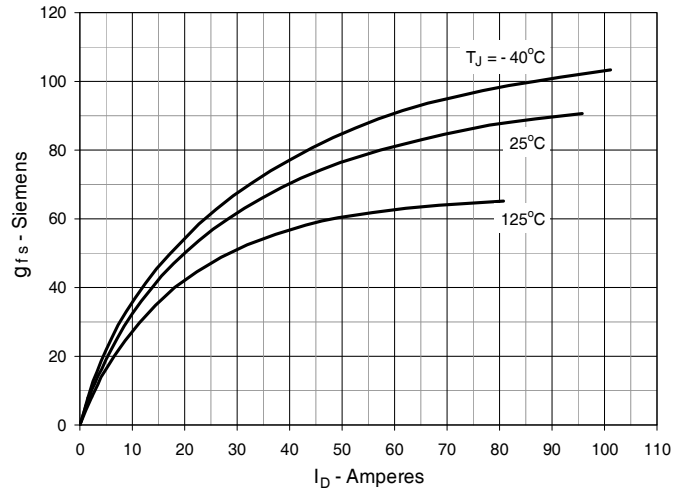


Fig. 9. Forward Voltage Drop of Intrinsic Diode

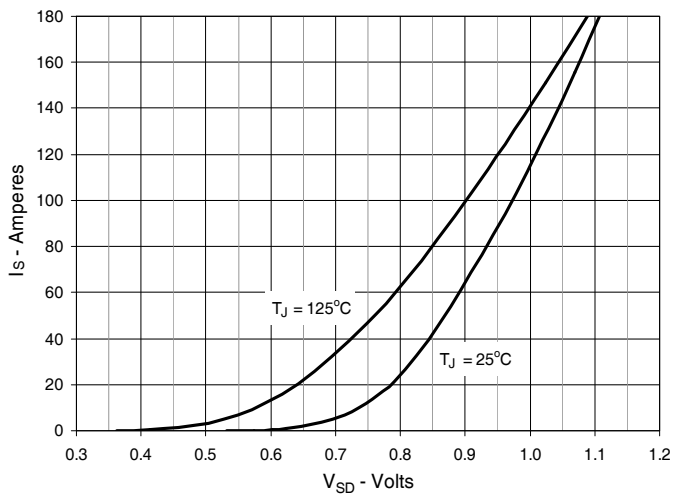


Fig. 10. Gate Charge

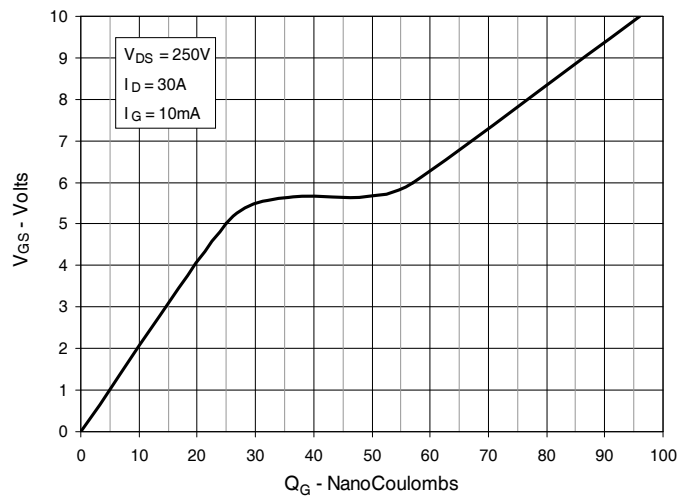


Fig. 11. Capacitance

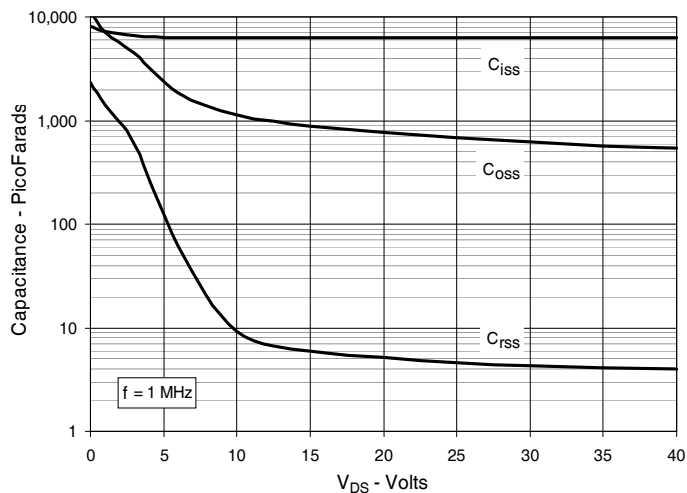


Fig. 12. Forward-Bias Safe Operating Area

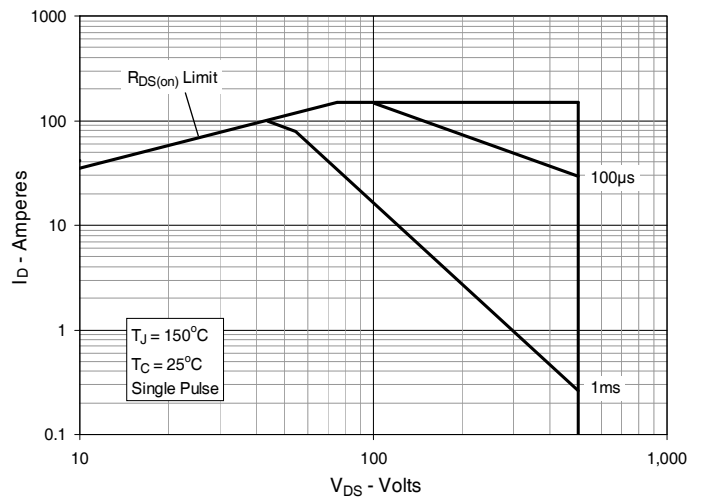
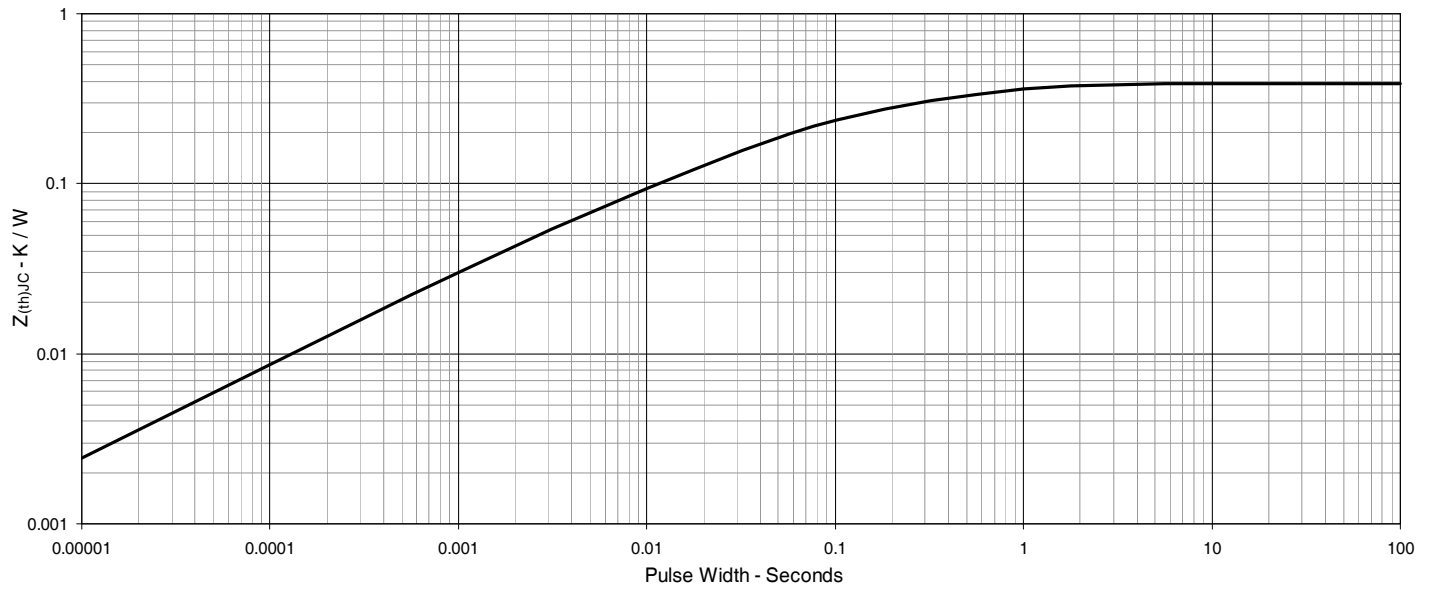
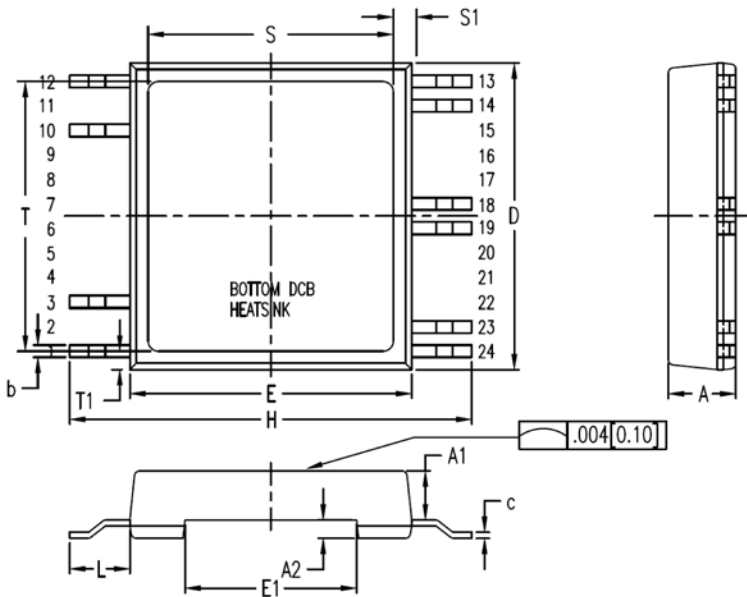
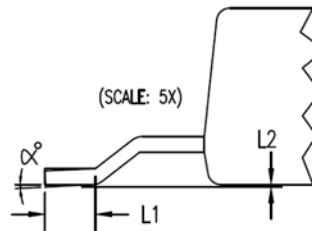
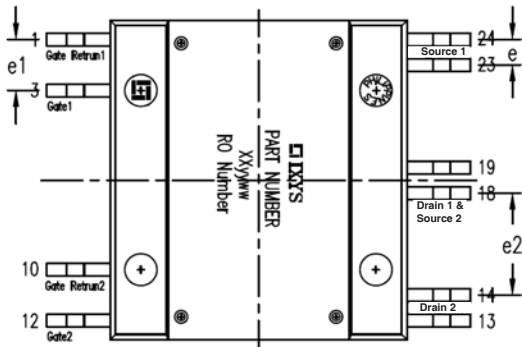


Fig. 13. Maximum Transient Thermal Impedance



SMPD OUTLINE


| SYM | INCHES | | MILLIMETERS | |
|-----|----------|-------|-------------|-------|
| | MIN | MAX | MIN | MAX |
| A | .209 | .224 | 5.30 | 5.70 |
| A1 | .154 | .161 | 3.90 | 4.10 |
| A2 | .055 | .063 | 1.40 | 1.60 |
| b | .035 | .045 | 0.90 | 1.15 |
| c | .018 | .026 | 0.45 | 0.65 |
| D | .976 | .994 | 24.80 | 25.25 |
| E | .898 | .915 | 22.80 | 23.25 |
| E1 | .543 | .559 | 13.80 | 14.20 |
| e | .079 BSC | | 2.00 BSC | |
| e1 | .157 BSC | | 4.00 BSC | |
| e2 | .315 BSC | | 8.00 BSC | |
| H | 1.272 | 1.311 | 32.30 | 33.30 |
| L | .181 | .209 | 4.60 | 5.30 |
| L1 | .051 | .067 | 1.30 | 1.70 |
| L2 | .000 | .006 | 0.00 | 0.15 |
| S | .748 | .807 | 19.00 | 20.50 |
| S1 | .039 | .079 | 1.00 | 2.00 |
| T | .826 | .886 | 21.00 | 22.50 |
| T1 | .039 | .079 | 1.00 | 2.00 |
| α | 0 | 4° | 0 | 4° |





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